Notice of References Cited Application/Control No. 10/747,737 Examiner EMMANUEL S. LUK Applicant(s)/Patent Under Reexamination BAILEY ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,747,732	06-2004	Lee, Martin E.	355/75
*	В	US-6,597,434	07-2003	Van Dijsseldonk, Antonius J. J.	355/75
	U	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-			
	-	US-			
	J	US-			
	К	US-			
	L_	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
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	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	V					
	w					
	х					

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